





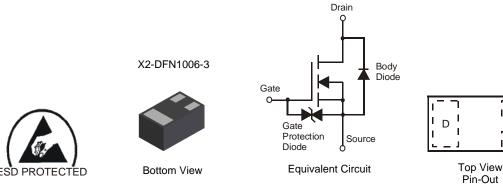
### N-CHANNEL ENHANCEMENT MODE MOSFET

### **Features**

- N-Channel MOSFET
- Low On-Resistance
- Very Low Gate Threshold Voltage, 1.2V max
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- Ultra-Small Surface Mount Package
- · ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

### **Mechanical Data**

- Case: X2-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.001 grams (approximate)



### **Ordering Information** (Note 4)

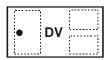
Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN32D2LFB4-7	DV	7	8	3000
DMN32D2LFB4-7B	DV	7	8	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

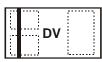
## **Marking Information**





Top View Dot Denotes Drain Side

### DMN32D2LFB4-7B



Top View Bar Denotes Gate and Source Side

DV = Product Type Marking Code



## Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Drain Source Voltage	$V_{DSS}$	30	V
Gate-Source Voltage	$V_{GSS}$	±10	V
Drain Current (Note 5)	Ι <sub>D</sub>	300	mA

# **Thermal Characteristics** @TA = 25°C unless otherwise specified

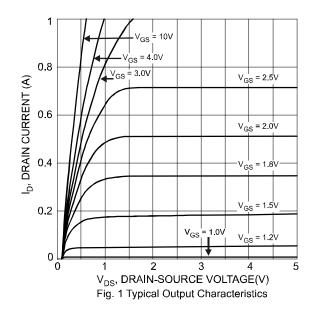
Total Power Dissipation (Note 5) @T <sub>A</sub> = 25°C	$P_{D}$	350	mW
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ hetaJA}$	357	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

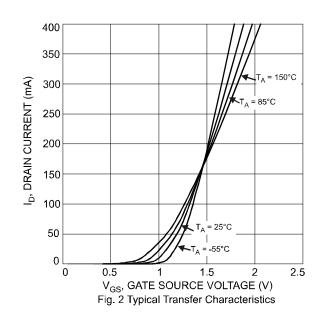
## Electrical Characteristics @TA = 25°C unless otherwise specified

Characteristic		Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current	@ T <sub>C</sub> = 25°C	I <sub>DSS</sub>		_	1	μА	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Body Leakage	I <sub>GSS</sub>	looo			±10	μΑ	$V_{GS} = \pm 10V$ , $V_{DS} = 0V$
Gale-Dody Leakage		_		±500	nA	$V_{GS} = \pm 5V$ , $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage		$V_{GS(th)}$	0.6	_	1.2	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
			_		2.2		$V_{GS} = 1.8V, I_D = 20mA$
Static Drain-Source On-Resistance		R <sub>DS</sub> (ON)	_	_	1.5	Ω	$V_{GS} = 2.5V, I_D = 20mA$
			_	_	1.2		$V_{GS} = 4.0V, I_D = 100mA$
Forward Transconductance		Y <sub>fs</sub>	100	_	_	mS	$V_{DS} = 10V, I_{D} = 0.1A$
Source-Drain Diode Forward Voltage		$V_{SD}$	0.5	_	1.4	V	$V_{GS} = 0V, I_{S} = 115mA$
DYNAMIC CHARACTERISTICS							
Input Capacitance		C <sub>iss</sub>	_	39	_	pF	., ., ., ., .,
Output Capacitance		Coss	_	10	_	pF	$V_{DS} = 3V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance		Crss	_	3.6	_	pF	1 = 1.0IVII IZ
Switching Time	Turn-on Time	t <sub>on</sub>	_	11	_	nS	$V_{DD} = 5V, I_D = 10 \text{ mA},$
Switching Time	Turn-off Time	t <sub>off</sub>	_	51	_	nS	$V_{GS} = 0.5V$

Notes:

<sup>6.</sup> Short duration pulse test used to minimize self-heating effect.





<sup>5.</sup> Device mounted on FR-4 PCB, pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com.



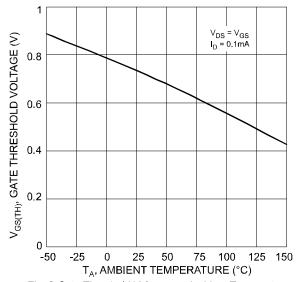


Fig. 3 Gate Threshold Voltage vs. Ambient Temperature

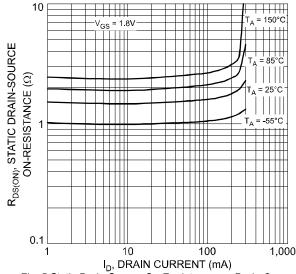


Fig. 5 Static Drain-Source On-Resistance vs. Drain Current

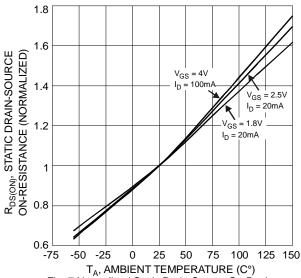


Fig. 7 Normalized Static Drain-Source On-Resistance vs. Ambient Temperature

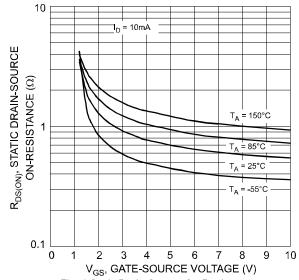
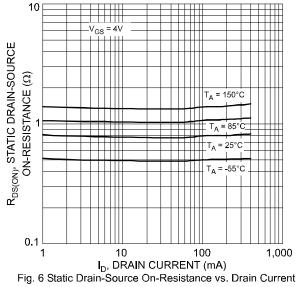


Fig. 4 Static Drain-Source On-Resistance vs. Gate-Source Voltage



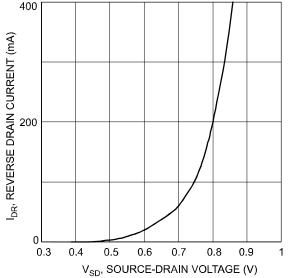
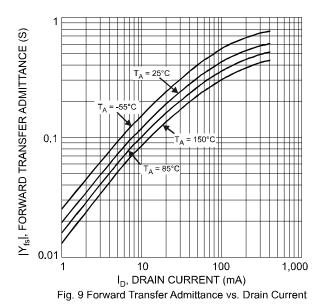
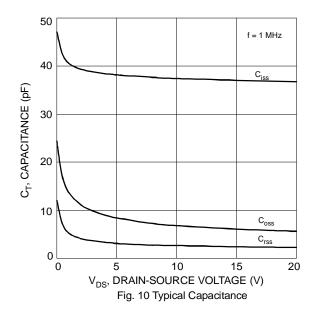


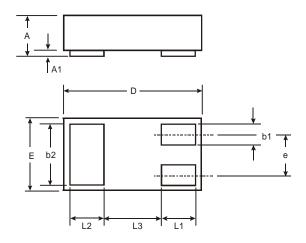
Fig. 8 Reverse Drain Current vs. Source-Drain Voltage





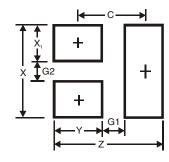


## **Package Outline Dimensions**



X2-DFN1006-3					
Dim	Min	Max	Тур		
Α	_	0.40	_		
A1	0	0.05	0.02		
b1	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.075	1.00		
Е	0.55	0.675	0.60		
е	_	_	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3			0.40		
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)
Z	1.1
G1	0.3
G2	0.2
Х	0.7
X1	0.25
Y	0.4
С	0.7



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